

July 2015

# **FDMS3008SDC** N-Channel Dual Cool<sup>TM</sup> 56 PowerTrench<sup>®</sup> SyncFET<sup>TM</sup> 30 V, 65 A, 2.6 m $\Omega$

### Features

- Dual Cool<sup>TM</sup> Top Side Cooling PQFN package
- Max  $r_{DS(on)} = 2.6 \text{ m}\Omega \text{ at } V_{GS} = 10 \text{ V}, I_D = 28 \text{ A}$
- Max  $r_{DS(on)}$  = 3.3 m $\Omega$  at V<sub>GS</sub> = 4.5 V, I<sub>D</sub> = 22 A
- High performance technology for extremely low r<sub>DS(on)</sub>
- SyncFET Schottky Body Diode
- RoHS Compliant

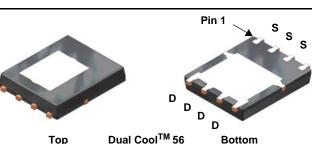


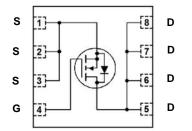
# **General Description**

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench<sup>®</sup> process. Advancements in both silicon and Dual Cool<sup>TM</sup> package technologies have been combined to offer the lowest  $r_{DS(on)}$  while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance. This device has the added benefit of an efficient monolithic Schottky body diode.

# Applications

- Synchronous Rectifier for DC/DC Converters
- Telecom Secondary Side Rectification
- High End Server/Workstation Vcore Low Side





**MOSFET Maximum Ratings**  $T_A = 25^{\circ}C$  unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DS</sub>	Drain to Source Voltage			30	V	
V <sub>GS</sub>	Gate to Source Voltage		(Note 4)	±20	V	
	Drain Current -Continuous (Package limited)	T <sub>C</sub> = 25 °C		65	A	
	-Continuous (Silicon limited)	T <sub>C</sub> = 25 °C		140		
D	-Continuous	T <sub>A</sub> = 25 °C	(Note 1a)	29		
	-Pulsed			200		
E <sub>AS</sub>	Single Pulse Avalanche Energy (Note 3)		(Note 3)	112	mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 5)	2.3	V/ns	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25 °C		78		
	Power Dissipation	T <sub>A</sub> = 25 °C	(Note 1a)	3.3	W	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Ra	ange		-55 to +150	°C	

### **Thermal Characteristics**

$R_{\thetaJC}$	Thermal Resistance, Junction to Case	(Top Source)	3.5	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.6	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	°C/W
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
3008S	FDMS3008SDC	Dual Cool <sup>™</sup> 56	13"	12 mm	3000 units

FDMS3008SDC
N-Channel Dual Cool
R
56 PowerTrench <sup>®</sup> (
SyncFET <sup>TM</sup>

Drain to Source Breakdown Voltage Breakdown Voltage Temperature Coefficient					
Breakdown Voltage Temperature					
	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0 V	30			V
	$I_D = 10$ mA, referenced to 25°C		13		mV/°C
Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$			500	μA
Gate to Source Leakage Current, Forward	$V_{GS} = 20 V, V_{DS} = 0 V$			100	nA
cteristics					
	$V_{00} = V_{00}$ $l_0 = 1$ mA	12	19	3.0	V
Gate to Source Threshold Voltage	$I_D = 10$ mA, referenced to 25°C		-5	0.0	mV/°C
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 28 A		1.8	2.6	
Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 22 \text{ A}$		2.7	3.3	mΩ
	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 28 \text{ A}, \text{ T}_{J} = 125^{\circ}\text{C}$		2.4	3.6	
Forward Transconductance	$V_{DS} = 5 V, I_{D} = 28 A$		144		S
Input Capacitance Output Capacitance Reverse Transfer Capacitance Gate Resistance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1MHz		3400 1115 80	4520 1485 120	pF pF pF
Turn On Dalay Time			15	07	20
Turn-On Delay Time	-			27	ns
Rise Time	$V_{DD} = 15 V, I_D = 28 A,$		4.7	10	ns
Rise Time Turn-Off Delay Time	$V_{\text{DD}} = 15 \text{ V}, \text{ I}_{\text{D}} = 28 \text{ A}, \\ V_{\text{GS}} = 10 \text{ V}, \text{ R}_{\text{GEN}} = 6 \Omega$		4.7 33	10 53	ns ns
Rise Time Turn-Off Delay Time Fall Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		4.7 33 3	10 53 10	ns ns ns
Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge	$V_{GS} = 10 \text{ V},  \text{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V} \text{ to } 10 \text{ V}$		4.7 33 3 46	10 53 10 64	ns ns ns nC
Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge	$V_{GS} = 10$ V, $R_{GEN} = 6$ Ω $V_{GS} = 0$ V to 10 V $V_{GS} = 0$ V to 4.5 V $V_{DD} = 15$ V,		4.7 33 3 46 21	10 53 10	ns ns nS nC nC
Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge	$V_{GS} = 10 \text{ V},  \text{R}_{GEN} = 6 \Omega$ $V_{GS} = 0 \text{ V} \text{ to } 10 \text{ V}$		4.7 33 3 46 21 9.6	10 53 10 64	ns ns nC nC nC
Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge         Gate to Drain "Miller" Charge	$V_{GS} = 10$ V, $R_{GEN} = 6$ Ω $V_{GS} = 0$ V to 10 V $V_{GS} = 0$ V to 4.5 V $V_{DD} = 15$ V,		4.7 33 3 46 21	10 53 10 64	ns ns nS nC nC
Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge         Gate to Drain "Miller" Charge         urce Diode Characteristics	$V_{GS} = 10 \text{ V},        $		4.7 33 3 46 21 9.6 4.3	10 53 10 64 29	ns ns nC nC nC
Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge         Gate to Drain "Miller" Charge	$V_{GS} = 10 \text{ V},        $		4.7 33 3 46 21 9.6	10 53 10 64	ns ns nC nC nC
Rise Time         Turn-Off Delay Time         Fall Time         Total Gate Charge         Total Gate Charge         Gate to Source Charge         Gate to Drain "Miller" Charge         urce Diode Characteristics	$V_{GS} = 10 \text{ V},        $		4.7 33 3 46 21 9.6 4.3	10 53 10 64 29 0.8	ns ns nC nC nC nC
	Temperature Coefficient         Static Drain to Source On Resistance         Forward Transconductance         Characteristics         Input Capacitance         Output Capacitance         Reverse Transfer Capacitance         Gate Resistance         Characteristics	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$ Gate to Source Threshold Voltage Temperature Coefficient $I_D = 10 \text{ mA}$ , referenced to 25°CStatic Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ VGS = 10 V, $I_D = 28 \text{ A}$ $V_{GS} = 4.5 \text{ V}$ , $I_D = 22 \text{ A}$ VGS = 10 V, $I_D = 28 \text{ A}$ , $T_J = 125°C$ Forward Transconductance $V_{DS} = 5 \text{ V}$ , $I_D = 28 \text{ A}$ CharacteristicsInput Capacitance $V_{DS} = 15 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ Reverse Transfer Capacitance $f = 1 \text{ MHz}$ Gate Resistance $Q$ CharacteristicsCharacteristics	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$ 1.2Gate to Source Threshold Voltage Temperature Coefficient $I_D = 10 \text{ mA}$ , referenced to 25°C1Static Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ 1VGS = 10 V, $I_D = 28 \text{ A}$ $V_{GS} = 4.5 \text{ V}$ , $I_D = 22 \text{ A}$ 1Forward Transconductance $V_{DS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ 1CharacteristicsInput Capacitance Output Capacitance $V_{DS} = 5 \text{ V}$ , $I_D = 28 \text{ A}$ Reverse Transfer Capacitance Gate Resistance $V_{DS} = 15 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ 1CharacteristicsImput CapacitanceImput CapacitanceImput CapacitanceCharacteristicsImput CapacitanceImput CapacitanceImput CapacitanceGate ResistanceImput CapacitanceImput CapacitanceImput CapacitanceImput CapacitanceImput CapacitanceImput Capacitance<	Gate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$ 1.21.9Gate to Source Threshold Voltage Temperature Coefficient $I_D = 10 \text{ mA}$ , referenced to 25°C-5Static Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ 1.8 $V_{GS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ 2.7 $V_{GS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ 2.4Forward Transconductance $V_{DS} = 5 \text{ V}$ , $I_D = 28 \text{ A}$ 144CharacteristicsInput Capacitance $V_{DS} = 15 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ 3400Output Capacitance $V_{DS} = 15 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ 0.7Characteristics0.7	Gate to Source Threshold Voltage Gate to Source Threshold Voltage Temperature Coefficient $V_{GS} = V_{DS}$ , $I_D = 1 \text{ mA}$ 1.21.93.0Gate to Source Threshold Voltage Temperature Coefficient $I_D = 10 \text{ mA}$ , referenced to 25°C-5-5Static Drain to Source On Resistance $V_{GS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ 1.82.6 $V_{GS} = 4.5 \text{ V}$ , $I_D = 22 \text{ A}$ 2.73.3 $V_{GS} = 10 \text{ V}$ , $I_D = 28 \text{ A}$ , $T_J = 125^{\circ}$ C2.43.6Forward Transconductance $V_{DS} = 5 \text{ V}$ , $I_D = 28 \text{ A}$ 144CharacteristicsInput Capacitance Output Capacitance $V_{DS} = 15 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{MHz}$ 34004520Quadratice $V_{DS} = 15 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1 \text{ MHz}$ 34004520Output Capacitance0.70.7Gate Resistance0.7Characteristics

b. 81 °C/W when mounted on

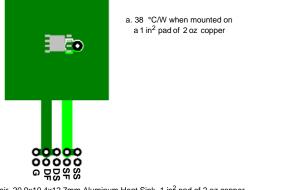
a minimum pad of 2 oz copper

## **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Top Source)	3.5	
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	1.6	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	16	9 <b>0</b> (M)
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
R <sub>0JA</sub>	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
R <sub>0JA</sub>	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

NOTES:

1. R<sub>0JA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>0JC</sub> is guaranteed by design while R<sub>0CA</sub> is determined by the user's board design.



c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in^2 pad of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

g. 200FPM Airflow, No Heat Sink,1 in<sup>2</sup> pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

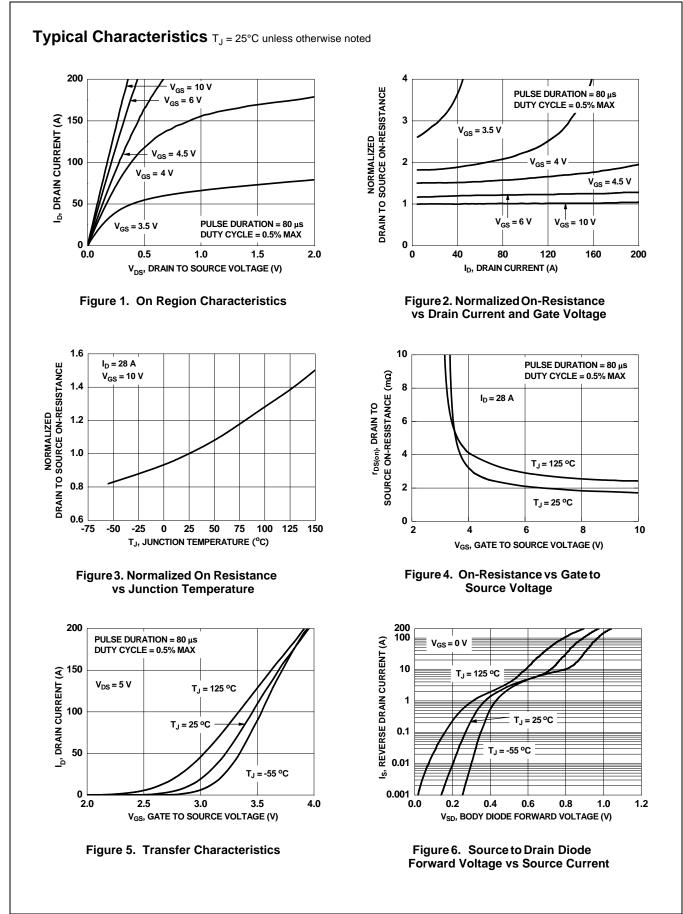
k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in<sup>2</sup> pad of 2 oz copper

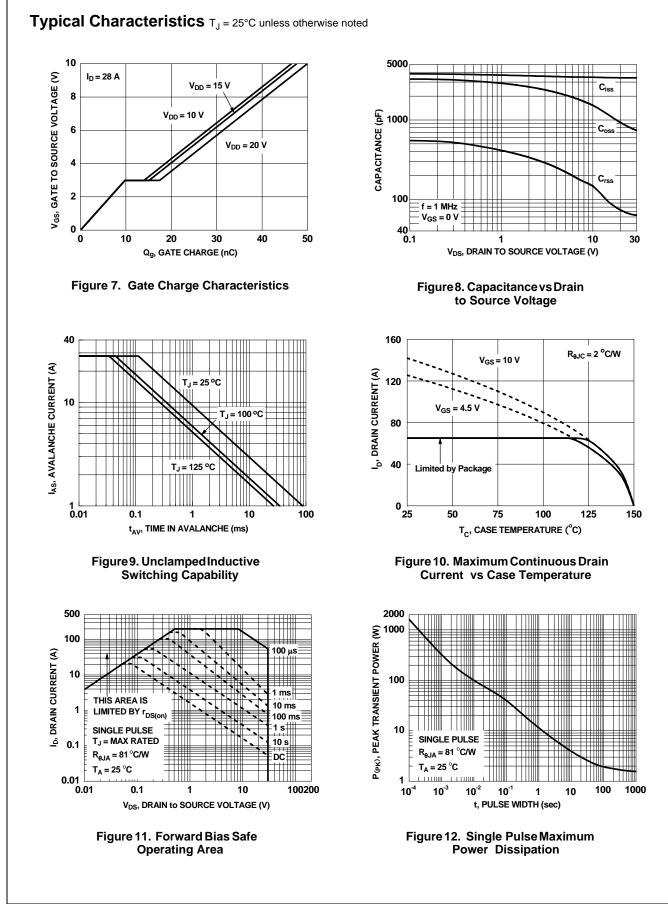
I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

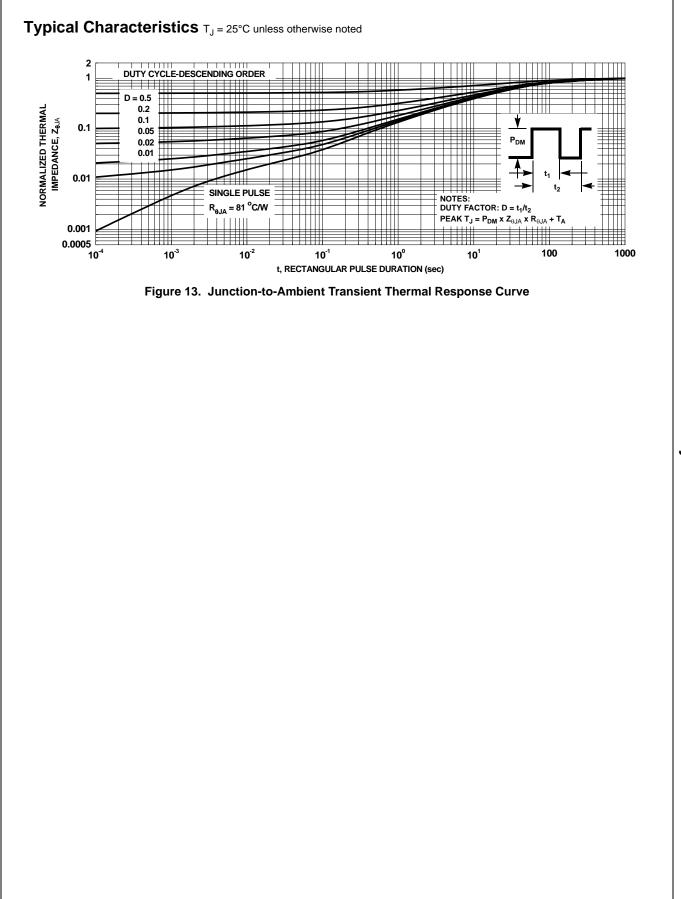
2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.

3.  $E_{AS}$  of 112 mJ is based on starting  $T_J$  = 25 °C, L = 1 mH,  $I_{AS}$  = 15 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V. 100% test at L = 0.1 mH,  $I_{AS}$  = 33.4 A.









# Typical Characteristics (continued)

### SyncFET Schottky body diode Characteristics

Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 14 shows the reverse recovery characteristic of the FDMS3008SDC.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

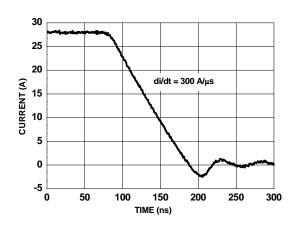
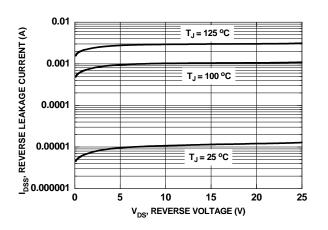
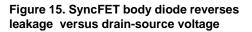
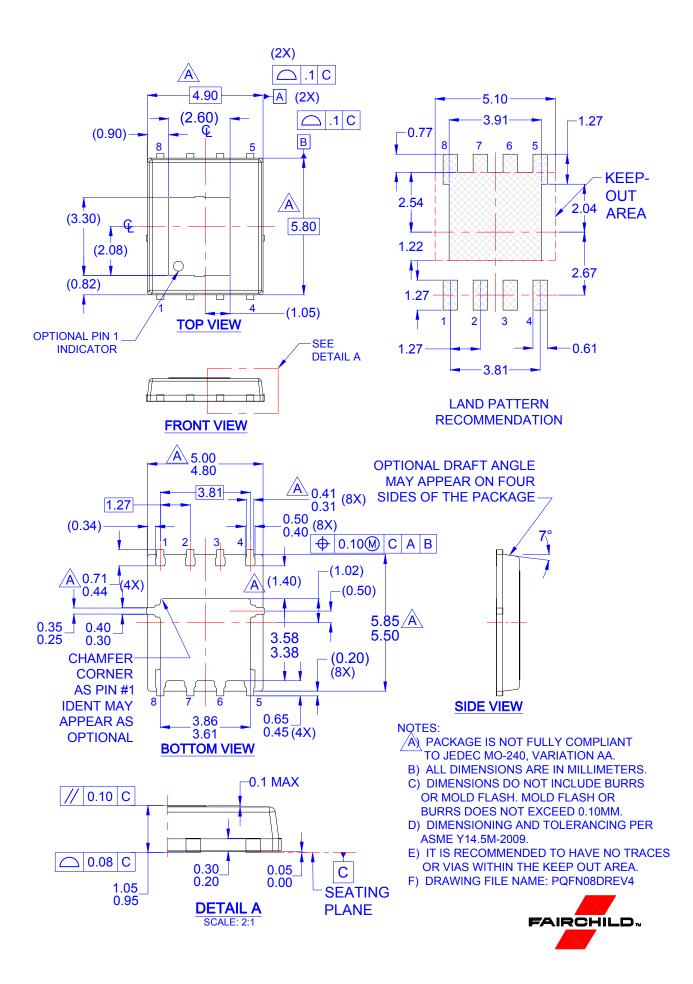


Figure 14. FDMS3008SDC SyncFET body diode reverse recovery characteristic









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